www.ps.bam.de/NE32/10S/S32E00F1.PS/.TXT; linearized output
F: Output Linearization (OL) data NE32/10S/S32E00F1.DAT in File (F)

Input: Colorimetric Offset Reflective System ORS18

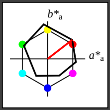
for hue h* = lab*h = 38/360 = 0.105

LAB*LCH, LAB*NCH

D65: hue O

LCH*Ma: 48 83 38

olv*Ma: 1.0 0.0 0.0



ORS18; adapted (a) CIELAB data	$L^*=L^*_a$	a^*_a	b^*_a	$C^*_{ab,a}$	$h^*_{ab,a}$
O_{Ma}	47.94	65.39	50.52	82.63	38
Y_{Ma}	90.37	−10.26	91.75	92.32	96
L_{Ma}	50.9	−62.83	34.96	71.91	151
C_{Ma}	58.62	−30.34	−45.01	54.3	236
V_{Ma}	25.72	31.1	−44.4	54.22	305
M_{Ma}	48.13	75.28	−8.36	75.74	354
N_{Ma}	18.01	0.0	0.0	0.0	0
W_{Ma}	95.41	0.0	0.0	0.0	0
R_{CIE}	39.92	58.66	26.98	64.57	25
J_{CIE}	81.26	−2.16	67.76	67.79	92
G_{CIE}	52.23	−42.25	11.76	43.87	164
B_{CIE}	30.57	1.15	−46.84	46.86	271

%Gamut

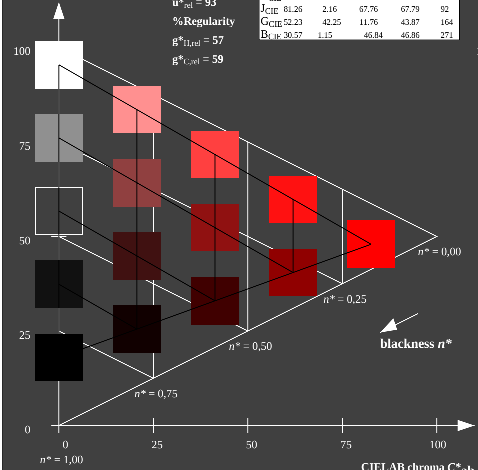
u^*_{rel} = 93

%Regularity

$g^*_{H,rel}$ = 57

$g^*_{C,rel}$ = 59

CIELAB lightness *L**



Output: Colorimetric Standard Reflective System SRS18

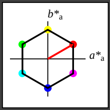
for hue h* = lab*h = 30/360 = 0.083

LAB*LCH, LAB*NCH

D65: hue O

LCH*Ma: 57 77 30

olv*Ma: 1.0 0.0 0.0



SRS18; adapted (a) CIELAB data	$L^*=L^*_a$	a^*_a	b^*_a	$C^*_{ab,a}$	$h^*_{ab,a}$
O_{Ma}	56.71	67.03	38.7	77.4	30
Y_{Ma}	56.71	0.0	77.4	77.4	90
L_{Ma}	56.71	−67.02	38.7	77.4	150
C_{Ma}	56.71	−67.02	−38.69	77.4	210
V_{Ma}	56.71	0.0	−77.39	77.4	270
M_{Ma}	56.71	67.03	−38.69	77.4	330
N_{Ma}	18.01	0.0	0.0	0.0	0
W_{Ma}	95.41	0.0	0.0	0.0	0
R_{CIE}	39.92	58.74	27.99	65.07	25
J_{CIE}	81.26	−2.88	71.56	71.62	92
G_{CIE}	52.23	−42.41	13.6	44.55	162
B_{CIE}	30.57	1.41	−46.46	46.49	272

%Gamut

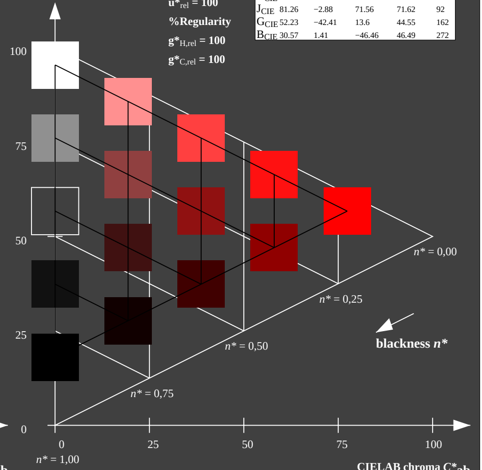
u^*_{rel} = 100

%Regularity

$g^*_{H,rel}$ = 100

$g^*_{C,rel}$ = 100

CIELAB lightness *L**



NE320−7, 5 step scales for constant CIELAB hue 38/360 = 0.105 (left) 5 step scales for constant CIELAB hue 30/360 = 0.083 (right)

BAM-test chart NE32; Colorimetric systems ORS18 & SRS18 input: *olv* setrgbcolor*
D65: Coordinate systems of 5 step colour scales for 10 hues output: *olv* setrgbcolor / w* setgray*

See for similar files: http://www.ps.bam.de/NE32/
Technical information: http://www.ps.bam.de Version 2.1, io=1,1, CIELAB

BAM registration: 20060101-NE32/10S/S32E00F1.PS/.TXT
application for evaluation and measurement of printer or monitor systems
BAM material: code=rha4ta

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